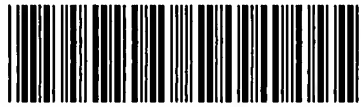


<b>Search Notes</b>  	<b>Application/Control No.</b>  10530962	<b>Applicant(s)/Patent Under Reexamination</b>  PERBEN ET AL.
	<b>Examiner</b>  Vo, Tuyen Kim	<b>Art Unit</b>  2876

SEARCHED			
Class	Subclass	Date	Examiner
235	441	06/28/2007	tkv
439	326, 629, 630, 632	07/03/2007	tkv

SEARCH NOTES		
Search Notes	Date	Examiner
East	6/28/2007	tkv
Consulted with Michael Lee, SPE on references and allowable subject matter (claims 1-7)	7/3/2007	tkv
Consulted with Truc Nguyen, primary on search help	7/3/2007	tkv

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner